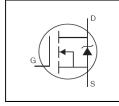


AUTOMOTIVE GRADE

AUIRFP2602

Features

- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{(BR)DSS}	24V
R _{DS(on)} typ.	1.25m Ω
max.	1.6mΩ
I _D (Silicon Limited)	380A®
D (Package Limited)	180A



G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Base part number Backage Type		Standard Pack Orderab		Ordershie Bert Number
Base part number	Package Type	Form Quantity		Orderable Part Number
AUIRFP2602	TO-247AC	Tube	25	AUIRFP2602

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	380®	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	270®	A
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	180] ^
I _{DM}	Pulsed Drain Current ①	1580	
P _D @T _C = 25°C	Maximum Power Dissipation	380	W
	Linear Derating Factor	2.5	W/°C
V _{GS} Gate-to-Source Voltage		± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) ②		400	I
E _{AS (Tested)}	E _{AS (Tested)} Single Pulse Avalanche Energy Tested Value ©		- mJ
I _{AR}	Avalanche Current ①	See Fig.14,15, 17a, 17b	А
E _{AR}	Repetitive Avalanche Energy ®		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG} Storage Temperature Range			°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

Symbol	Symbol Parameter			Units
$R_{\theta JC}$	Junction-to-Case ⑦		0.40	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.24		°C/W
$R_{\theta JA}$	Junction-to-Ambient		40	

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	24			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.02		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		1.25	1.6	mΩ	$V_{GS} = 10V, I_D = 180A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	230			S	$V_{DS} = 10V, I_{D} = 180A$
	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$
I _{DSS}				250	μΑ	$V_{DS} = 24V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			200	nA	$V_{GS} = 20V$
				-200	IIA	$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 260	390		I _D = 180A
Q_{gs}	Gate-to-Source Charge	 72			$V_{DS} = 12V$
Q_{gd}	Gate-to-Drain Charge	 100			V _{GS} = 10V ③
t _{d(on)}	Turn-On Delay Time	 70			V _{DD} = 12V
t _r	Rise Time	 490			I _D = 180A
t _{d(off)}	Turn-Off Delay Time	 150		ne .	$R_G = 2.5\Omega$
t _f	Fall Time	 270			V _{GS} = 10V ③
L _D	Internal Drain Inductance	 5.0			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 13			from package and center of die contact
C _{iss}	Input Capacitance	 11220			$V_{GS} = 0V$
Coss	Output Capacitance	 4800		pF	V _{DS} = 19V
C_{rss}	Reverse Transfer Capacitance	 2660			f = 1.0 KHz
C _{oss}	Output Capacitance	 13020			$V_{GS}=0V, V_{DS}=1.0V, f = 1.0KHz$
C _{oss}	Output Capacitance	4800			$V_{GS}=0V, V_{DS}=19V, f = 1.0KHz$
Coss eff.	Effective Output Capacitance	 6710			$V_{GS} = 0V$, $V_{DS} = 0V$ to 19V $\textcircled{4}$

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			380®		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			1580		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 180A, V_{GS} = 0V$ 3
t _{rr}	Reverse Recovery Time		55	83	ns	$T_J = 25^{\circ}\text{C}, I_F = 180\text{A}, V_{DD} = 12\text{V}$
Q_{rr}	Reverse Recovery Charge		56	84	nC	di/dt = 100A/μs ③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

- ① Repetitive rating; pulse width limited by max. junction temperature. (See Fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25^{\circ}C$, L = 0.025mH, $R_G = 25\Omega$, $I_{AS} = 180$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- ③ Pulse width ≤ 1.0ms; duty cycle ≤ 2%.
 ④ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while VDS is rising from 0 to 80% V_{DSS}.
 ⑤ Limited by TJmax , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- © This value determined from sample failure population. 100% tested to this value in production.
- ⑦ R_θ is measured at T_J of approximately 90°C.
- ® Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 180A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.



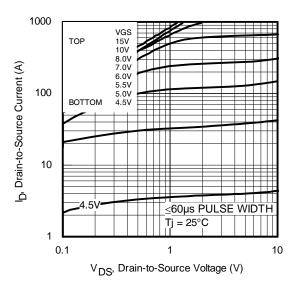


Fig. 1 Typical Output Characteristics

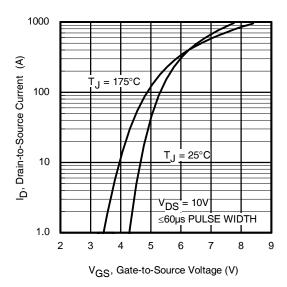


Fig. 3 Typical Transfer Characteristics

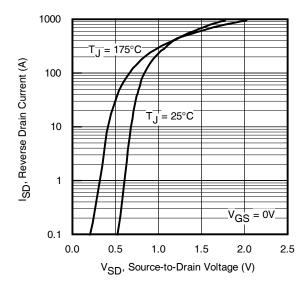


Fig 5. Typical Source-Drain Diode Forward Voltage

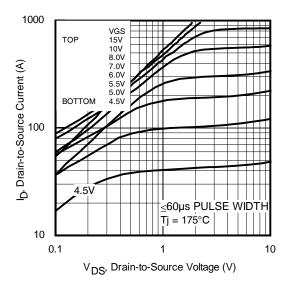


Fig. 2 Typical Output Characteristics

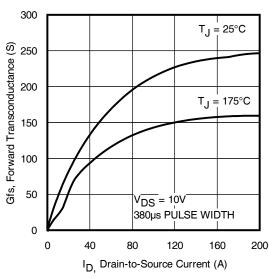


Fig. 4 Typical Forward Transconductance vs. Drain Current

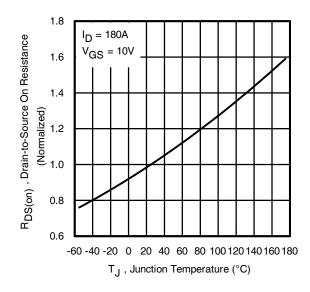


Fig 6. Normalized On-Resistance vs. Temperature



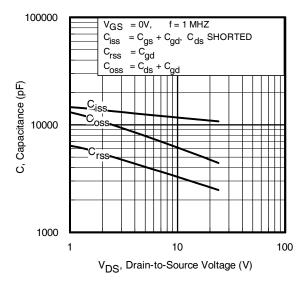


Fig. 7 Typical Capacitance vs. Drain-to-Source Voltage

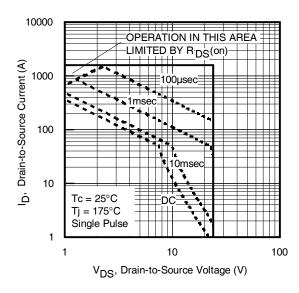


Fig 9. Maximum Safe Operating Area

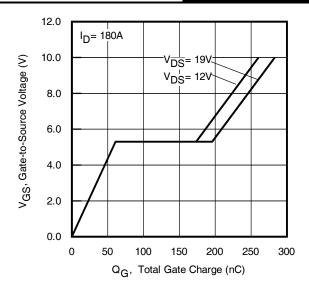


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage

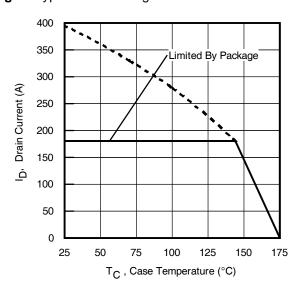


Fig 10. Maximum Drain Current vs. Case Temperature

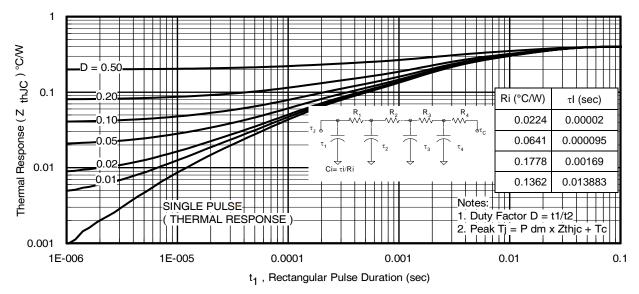
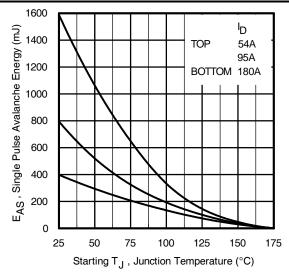


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case





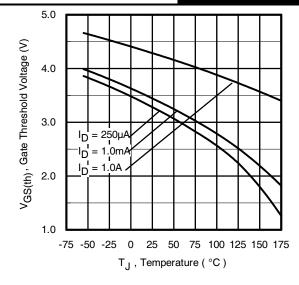


Fig 12. Maximum Avalanche Energy vs. Drain Current

Fig 13. Threshold Voltage vs. Temperature

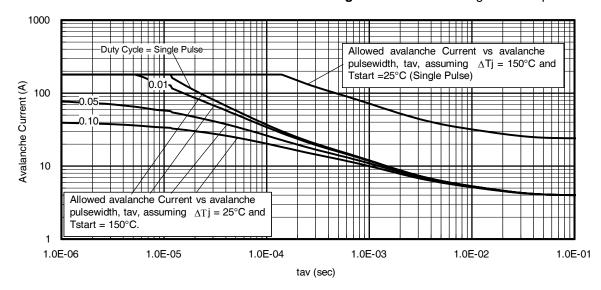
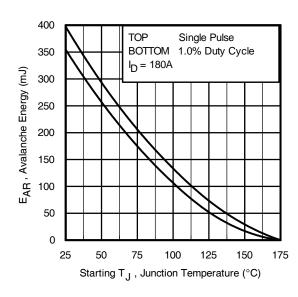


Fig 14. Typical Avalanche Current vs. Pulse width



Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.infineon.com)

excess of T_{jmax}. This is validated for every part type.

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 17a, 17b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
 - tav = Average time in avalanche.
 - $D = Duty cycle in avalanche = tav \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \text{-BV-I}_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \text{-BV-Z}_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

Fig 15. Maximum Avalanche Energy vs. Temperature

5 2016-2-16



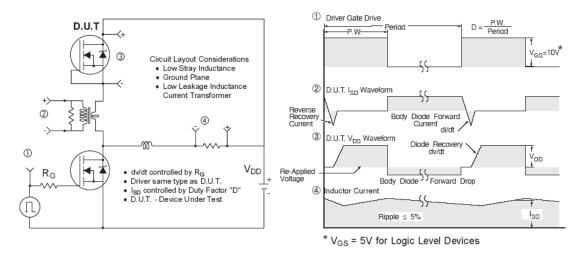


Fig 16. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

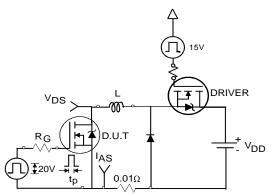


Fig 17a. Unclamped Inductive Test Circuit

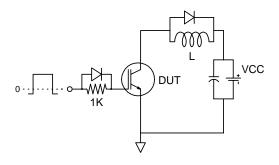


Fig 18a. Gate Charge Test Circuit

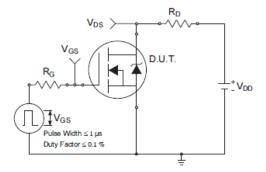


Fig 19a. Switching Time Test Circuit

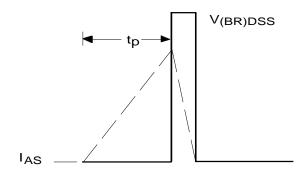


Fig 17b. Unclamped Inductive Waveforms

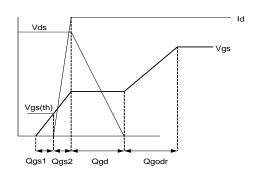


Fig 18b. Gate Charge Waveform

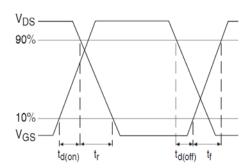
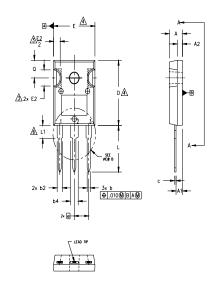
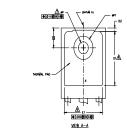


Fig 19b. Switching Time Waveforms



TO-247AC Package Outline (Dimensions are









NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
- 2. DIMENSIONS ARE SHOWN IN INCHES.

<u>√3</u>.\ co

CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

5) THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

ØP TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 * TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

	DIMENSIONS				
SYMBOL	INC	HES	MILLIM	ETERS	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
ь1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
е	.215	BSC	5.46	BSC	
Øk	.0	10	0.	25	
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
øΡ	.140	.144	3.56	3.66	
øP1	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	
		_			1

LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

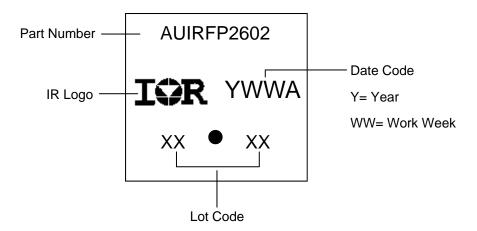
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

TO-247AC Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

			A (
		Automotive				
		(per AEC-Q101)				
Qualifica	tion Level	Comments: Th	is part number(s) passed Automotive qualification. Infineon's			
		Industrial and C	Consumer qualification level is granted by extension of the higher			
		Automotive level.				
Moisture	Sensitivity Level	TO-247AC	N/A			
	Marakina Maraka		Class M4 (+/- 800V) [†]			
	Machine Model	AEC-Q101-002				
FOD	Livers on Darky Mandal	Class H2 (+/- 4000V) [†]				
ESD	Human Body Model	AEC-Q101-001				
	Channel Davis Madal	Class C5 (+/- 2000V) [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Co	mpliant	Yes				

[†] Highest passing voltage.

Revision History

Date	Comments					
2/16/2016	Updated datasheet with corporate template					
2/10/2016	 Corrected typo, Capacitance test condition from VDS=25V to VDS=19V on page 2 					

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